Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/003,720	DEW ET AL.
Examiner	Art Unit

2614

Chris Parry

SEARCHED					
Class	Subclass	Date	Examiner		
725	37-39	12/2/2005	CLP		
725	46	12/2/2005	CLP		
725	85	12/2/2005	CLP		
725	78	12/2/2005	CLP		
725	13	12/2/2005	CLP		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
			-		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
See attached search strategy from EAST (USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB).	12/7/2005	CLP
Consulted Scott Beliveau on areas of search in class 725.	12/5/2005	CLP